## Search Notes



# Application/Control No.

1007474310016765

#### Examiner

Shang, Annan Q.Shang, Annan Q.

### Applicant(s)/Patent Under Reexamination

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#### Art Unit

24242424

### SEARCHED

Class	Subclass	Date	Examiner
725	58,78-85,131-134,139-142,106-120	09/09/10	/A.S./
709	217-231	09/09/10	/A.S./
345	169,553,556,173,716,717,722,901	09/09/10	/A.S./
348725	73432, 40-43, 48-51, 54-55, 86-92, 100-103, 114-115, 135-136	09/09/109/28/06	/A.S./JM

### SEARCH NOTES

Search Notes	Date	Examiner
EAST	10/1/2006	CML
EAST	4/30/2007	CML
Updated search	7/2/08	/A.S./
Updated search	1/26/09	/A.S./
Updated search	6/30/09	/A.S./
Updated search	12/16/09	/A.S./
Updated Search	04/06/10	/A.S./
Updated searchEAST Search included	09/09/109/28/06	/A.S./JM
Spoke with Scott Beliveau	9/28/06	JM
Updated search	6/11/08	/A.S./
Updated search	3/9/09	/A.S/
Updated search	03/23/10	/A.S./
Updated search	10/6/10	/A.S./

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
725	58,78-85,131-134,139-142,106-120	09/30/10	/A.S./
709	217-231	09/30/10	/A.S./
345	69,553,556,173,716,717,722,901	09/30/10	/A.S./
348	734	09/30/10	/A.S./